



RF Power Field Effect Transistors

N-Channel Enhancement-Mode Lateral MOSFETs

Designed for broadband commercial and industrial applications with frequencies up to 1000 MHz. The high gain and broadband performance of these devices make them ideal for large-signal, common-source amplifier applications in 28 volt base station equipment.

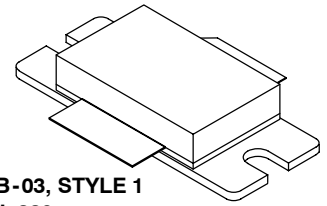
- Typical Single-Carrier W-CDMA Performance: $V_{DD} = 28$ Volts, $I_{DQ} = 1400$ mA, $P_{out} = 58$ Watts Avg., $f = 880$ MHz, 3GPP Test Model 1, 64 DPCH with 45.2% Clipping, Channel Bandwidth = 3.84 MHz, Input Signal PAR = 7.5 dB @ 0.01% Probability on CCDF.
Power Gain — 21 dB
Drain Efficiency — 35%
Device Output Signal PAR — 6.36 dB @ 0.01% Probability on CCDF
ACPR @ 5 MHz Offset — -40 dBc in 3.84 MHz Channel Bandwidth
- Capable of Handling 10:1 VSWR, @ 32 Vdc, 880 MHz, $P_{out} = 300$ W CW (3 dB Input Overdrive from Rated P_{out}), Designed for Enhanced Ruggedness.

Features

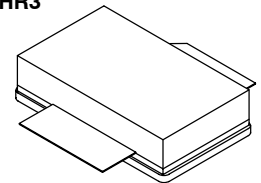
- 100% PAR Tested for Guaranteed Output Power Capability
- Characterized with Series Equivalent Large-Signal Impedance Parameters
- Internally Matched for Ease of Use
- Qualified Up to a Maximum of 32 V_{DD} Operation
- Integrated ESD Protection
- RoHS Compliant
- In Tape and Reel. R3 Suffix = 250 Units per 56 mm, 13 inch Reel.

MRFE6S9200HR3
MRFE6S9200HSR3

880 MHz, 58 W AVG., 28 V
SINGLE W-CDMA
LATERAL N-CHANNEL
RF POWER MOSFETs



CASE 465B-03, STYLE 1
NI-880
MRFE6S9200HR3



CASE 465C-02, STYLE 1
NI-880S
MRFE6S9200HSR3

Table 1. Maximum Ratings

Rating	Symbol	Value	Unit
Drain-Source Voltage	V_{DSS}	-0.5, +66	Vdc
Gate-Source Voltage	V_{GS}	-0.5, +12	Vdc
Storage Temperature Range	T_{stg}	-65 to +150	°C
Case Operating Temperature	T_C	150	°C
Operating Junction Temperature (1,2)	T_J	225	°C

Table 2. Thermal Characteristics

Characteristic	Symbol	Value (2,3)	Unit
Thermal Resistance, Junction to Case Case Temperature 80°C, 200 W CW Case Temperature 79°C, 58 W CW	$R_{\theta JC}$	0.29 0.33	°C/W

1. Continuous use at maximum temperature will affect MTTF.
2. MTTF calculator available at <http://www.freescale.com/rf>. Select Software & Tools/Development Tools/Calculators to access MTTF calculators by product.
3. Refer to AN1955, *Thermal Measurement Methodology of RF Power Amplifiers*. Go to <http://www.freescale.com/rf>. Select Documentation/Application Notes - AN1955.

Table 3. ESD Protection Characteristics

Test Methodology	Class
Human Body Model (per JESD22-A114)	1C (Minimum)
Machine Model (per EIA/JESD22-A115)	A (Minimum)
Charge Device Model (per JESD22-C101)	IV (Minimum)

Table 4. Electrical Characteristics ($T_C = 25^\circ\text{C}$ unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
Off Characteristics					
Zero Gate Voltage Drain Leakage Current ($V_{DS} = 66\text{ Vdc}$, $V_{GS} = 0\text{ Vdc}$)	I_{DSS}	—	—	10	μAdc
Zero Gate Voltage Drain Leakage Current ($V_{DS} = 28\text{ Vdc}$, $V_{GS} = 0\text{ Vdc}$)	I_{DSS}	—	—	1	μAdc
Gate-Source Leakage Current ($V_{GS} = 5\text{ Vdc}$, $V_{DS} = 0\text{ Vdc}$)	I_{GSS}	—	—	10	μAdc

On Characteristics

Gate Threshold Voltage ($V_{DS} = 10\text{ Vdc}$, $I_D = 600\ \mu\text{Adc}$)	$V_{GS(th)}$	1.2	2	2.7	Vdc
Gate Quiescent Voltage ($V_{DD} = 28\text{ Vdc}$, $I_D = 1400\ \text{mAdc}$, Measured in Functional Test)	$V_{GS(Q)}$	2	2.7	3.8	Vdc
Drain-Source On-Voltage ($V_{GS} = 10\text{ Vdc}$, $I_D = 4.1\ \text{Adc}$)	$V_{DS(on)}$	0.1	0.2	0.3	Vdc

Dynamic Characteristics (1)

Reverse Transfer Capacitance ($V_{DS} = 28\text{ Vdc} \pm 30\ \text{mV(rms)ac}$ @ 1 MHz, $V_{GS} = 0\text{ Vdc}$)	C_{rss}	—	2.41	—	pF
Output Capacitance ($V_{DS} = 28\text{ Vdc} \pm 30\ \text{mV(rms)ac}$ @ 1 MHz, $V_{GS} = 0\text{ Vdc}$)	C_{oss}	—	74.61	—	pF
Input Capacitance ($V_{DS} = 28\text{ Vdc}$, $V_{GS} = 0\text{ Vdc} \pm 30\ \text{mV(rms)ac}$ @ 1 MHz)	C_{iss}	—	557.27	—	pF

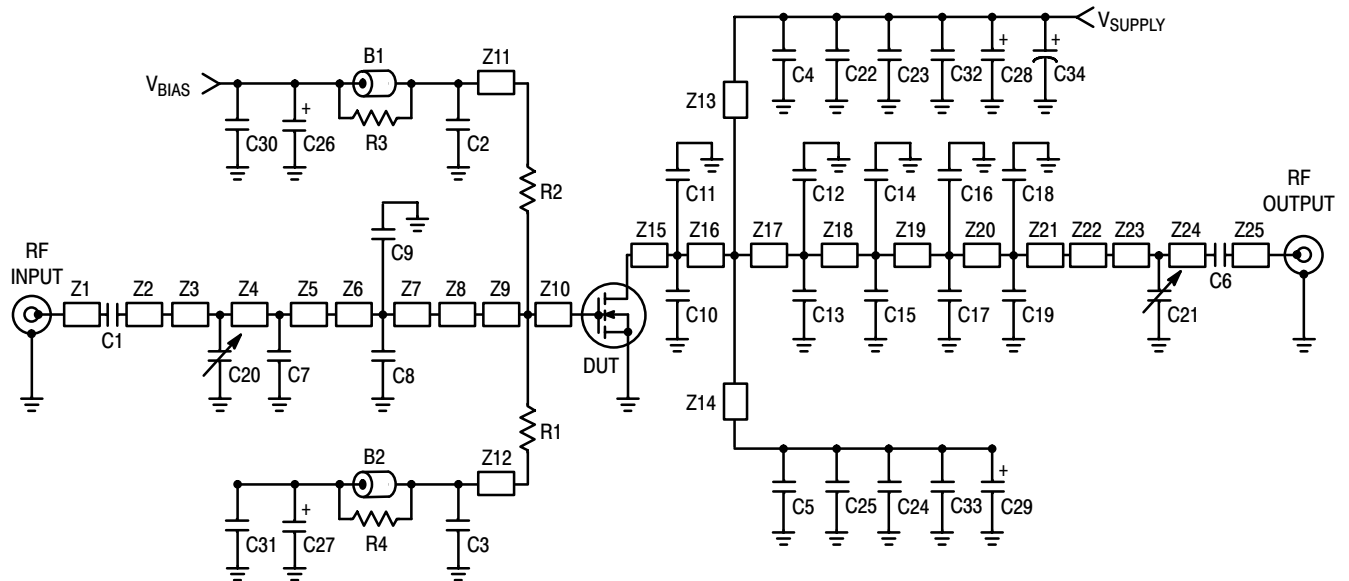
Functional Tests (In Freescale Test Fixture, 50 ohm system) $V_{DD} = 28\text{ Vdc}$, $I_{DQ} = 1400\ \text{mA}$, $P_{out} = 58\ \text{W Avg.}$ W-CDMA, $f = 880\ \text{MHz}$, Single-Carrier W-CDMA, 3.84 MHz Channel Bandwidth Carrier. ACPR measured in 3.84 MHz Channel Bandwidth @ 5 MHz Offset. PAR = 7.5 dB @ 0.01% Probability on CCDF.

Power Gain	G_{ps}	20	21	23	dB
Drain Efficiency	η_D	33	35	—	%
Output Peak-to-Average Ratio @ 0.01% Probability on CCDF	PAR	6	6.36	—	dB
Adjacent Channel Power Ratio	ACPR	—	-40	-36.5	dBc
Input Return Loss	IRL	—	-15	-9	dB

Typical Performances (In Freescale Test Fixture, 50 ohm system) $V_{DD} = 28\text{ Vdc}$, $I_{DQ} = 1400\ \text{mA}$, 865-900 MHz Bandwidth

Video Bandwidth @ 200 W PEP P_{out} where $IM3 = -30\ \text{dBc}$ (Tone Spacing from 100 kHz to VBW) $\Delta IM3 = IM3$ @ VBW frequency - $IM3$ @ 100 kHz < 1 dBc (both sidebands)	VBW	—	10	—	MHz
Gain Flatness in 35 MHz Bandwidth @ $P_{out} = 58\ \text{W Avg.}$	G_F	—	0.5	—	dB
Average Deviation from Linear Phase in 35 MHz Bandwidth @ $P_{out} = 200\ \text{W CW}$	Φ	—	0.28	—	°
Average Group Delay @ $P_{out} = 200\ \text{W CW}$, $f = 880\ \text{MHz}$	Delay	—	3.72	—	ns
Part-to-Part Insertion Phase Variation @ $P_{out} = 200\ \text{W CW}$, $f = 880\ \text{MHz}$, Six Sigma Window	$\Delta\Phi$	—	15.9	—	°
Gain Variation over Temperature (-30°C to +85°C)	ΔG	—	0.016	—	dB/°C
Output Power Variation over Temperature (-30°C to +85°C)	$\Delta P1\text{dB}$	—	0.008	—	dBm/°C

1. Part is internally matched on input.



Z1	0.351" x 0.080" Microstrip	Z9	0.119" x 0.118" Microstrip	Z19	0.074" x 0.669" x 0.707" Taper
Z2	0.538" x 0.080" Microstrip	Z10	0.305" x 0.980" Microstrip	Z20	0.074" x 0.524" x 0.595" Taper
Z3	0.424" x 0.080" Microstrip	Z11, Z12	2.134" x 0.070" Microstrip	Z21	0.058" x 0.474" x 0.488" Taper
Z4	0.052" x 0.220" Microstrip	Z13, Z14	1.885" x 0.100" Microstrip	Z22	0.326" x 0.491" Microstrip
Z5	0.414" x 0.220" Microstrip	Z15	0.100" x 1.090" Microstrip	Z23	0.708" x 0.220" Microstrip
Z6	0.052" x 0.491" Microstrip	Z16	0.212" x 1.090" Microstrip	Z24	0.555" x 0.080" Microstrip
Z7	0.140" x 0.491" Microstrip	Z17	0.083" x 0.962" x 1.036" Taper	Z25	0.356" x 0.080" Microstrip
Z8	0.244" x 0.736" x 0.980" Taper	Z18	0.074" x 0.816" x 0.888" Taper	PCB	Arlon CuClad 250GX-0300-55-22, 0.030", $\epsilon_r = 2.55$

Figure 1. MRFE6S9200HR3(SR3) Test Circuit Schematic

Table 5. MRFE6S9200HR3(SR3) Test Circuit Component Designations and Values

Part	Description	Part Number	Manufacturer
B1, B2	Small Ferrite Beads, Surface Mount	2743019447	Fair Rite
C1, C2, C3, C4, C5, C6	47 pF Chip Capacitors	ATC100B470JT500XT	ATC
C7	2.7 pF Chip Capacitor	ATC100B2R7JT500XT	ATC
C8, C9, C18, C19	1.3 pF Chip Capacitors	ATC100B1R3JT500XT	ATC
C10, C11	12 pF Chip Capacitors	ATC100B120JT500XT	ATC
C12, C13	4.3 pF Chip Capacitors	ATC100B4R3JT500XT	ATC
C14, C15, C16, C17	3.3 pF Chip Capacitors	ATC100B3R3JT500XT	ATC
C20	0.6-4.5 pF Variable Capacitor, Gigatrim	27271SL	Johanson
C21	0.8-8.0 pF Variable Capacitor, Gigatrim	27291SL	Johanson
C22, C23, C24, C25	10 μ F, 50 V Chip Capacitors	GRM55DR61H106KA88B	Murata
C26, C27	10 μ F, 35 V Tantalum Chip Capacitors	T491C106K035AT	Kemet
C28, C29	22 μ F, 35 V Tantalum Chip Capacitors	T491C226K035AT	Kemet
C30, C31, C32, C33	0.1 μ F Chip Capacitors	CDR33Bx104AKYS	Kemet
C34	330 μ F, 63 V Electrolytic Capacitor	EKMG630ELL331MJ205	United Chemi-Con
R1, R2, R3, R4	10 Ω , 1/4 W Chip Resistors	CRCW120610R0FKEA	Vishay

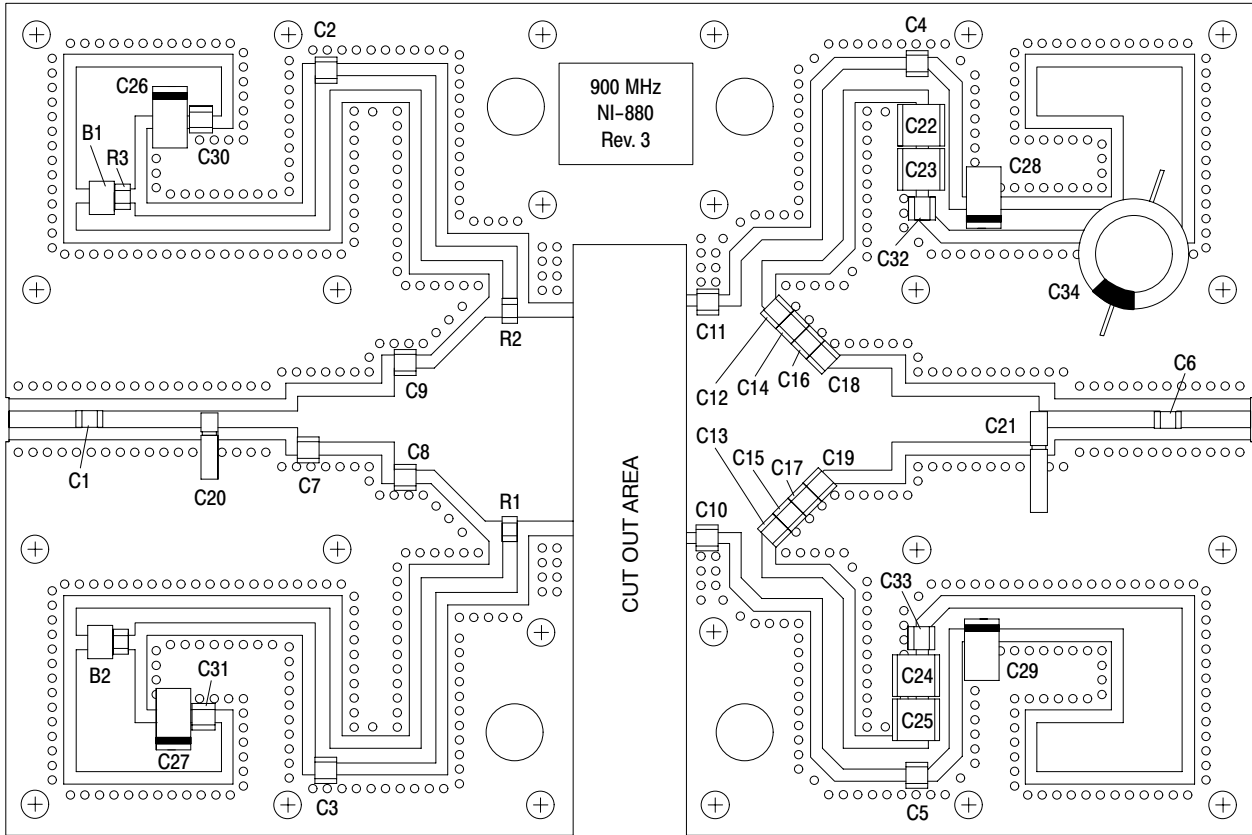


Figure 2. MRFE6S9200HR3(SR3) Test Circuit Component Layout

TYPICAL CHARACTERISTICS

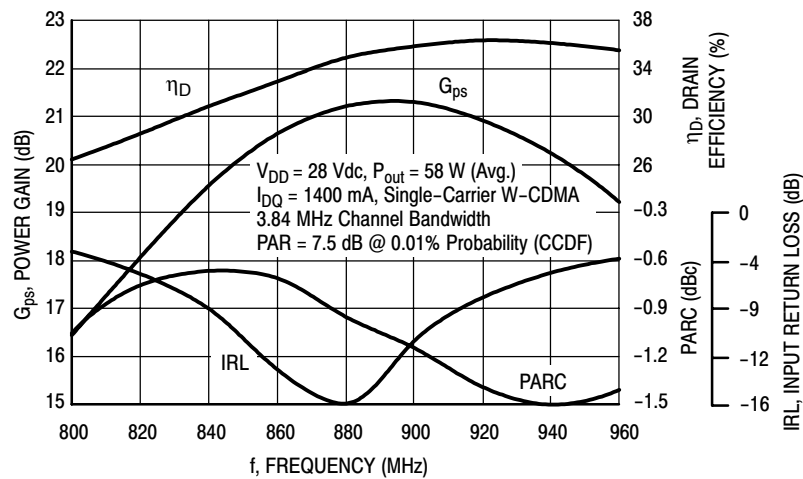


Figure 3. Single-Carrier W-CDMA Broadband Performance @ $P_{out} = 58$ Watts Avg.

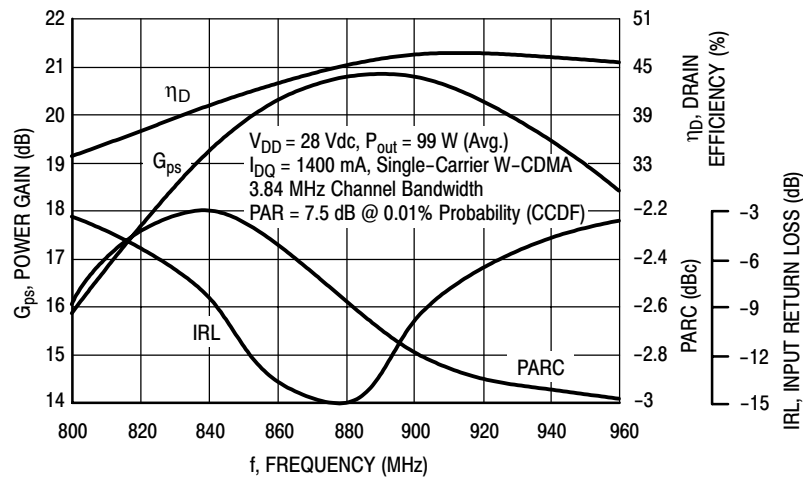


Figure 4. Single-Carrier W-CDMA Broadband Performance @ $P_{out} = 99$ Watts Avg.

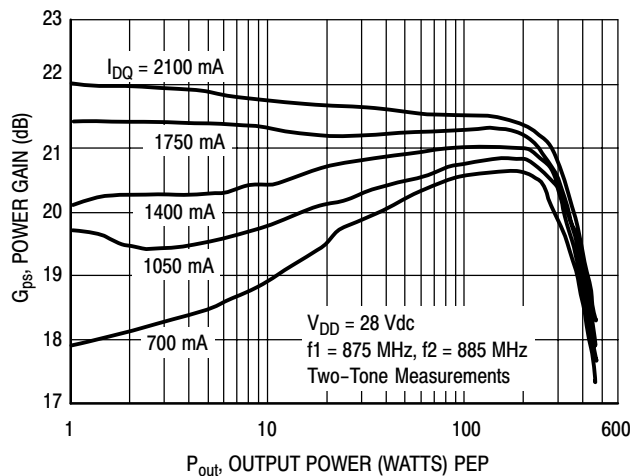


Figure 5. Two-Tone Power Gain versus Output Power

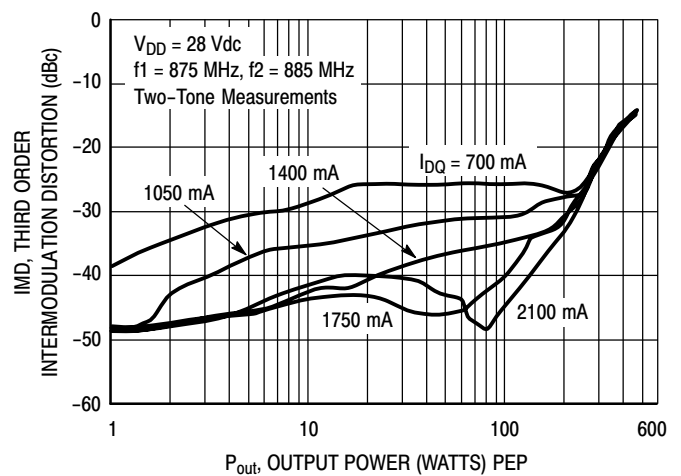


Figure 6. Third Order Intermodulation Distortion versus Output Power

TYPICAL CHARACTERISTICS

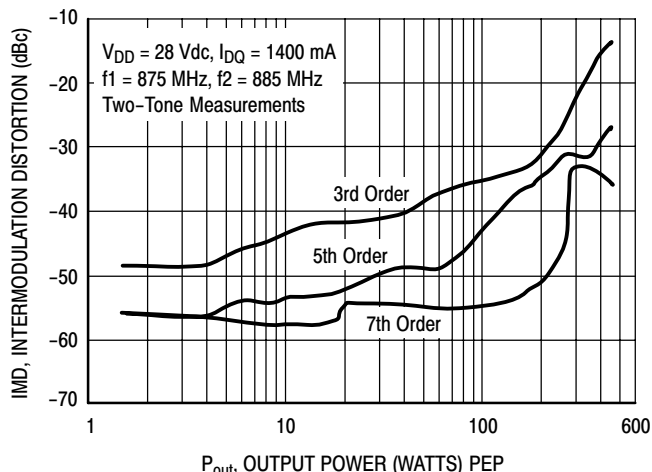


Figure 7. Intermodulation Distortion Products versus Output Power

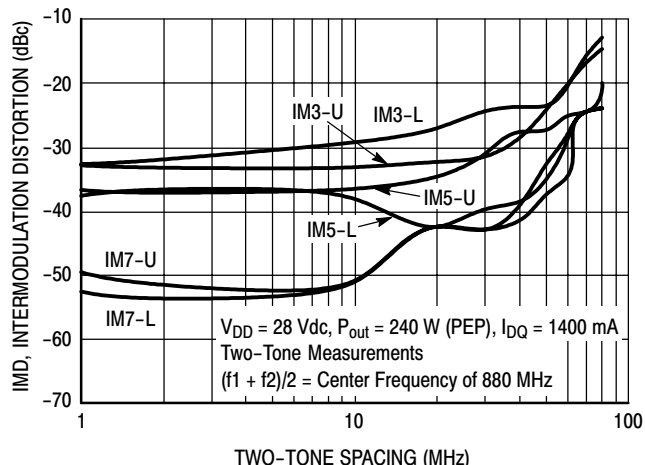


Figure 8. Intermodulation Distortion Products versus Tone Spacing

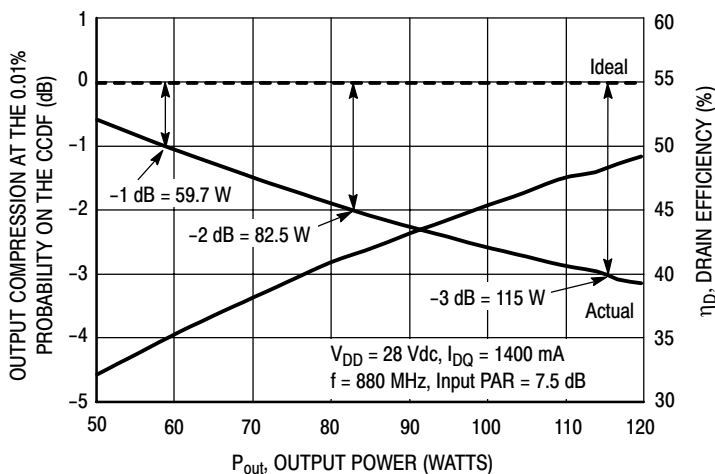


Figure 9. Output Peak-to-Average Ratio Compression (PARC) versus Output Power

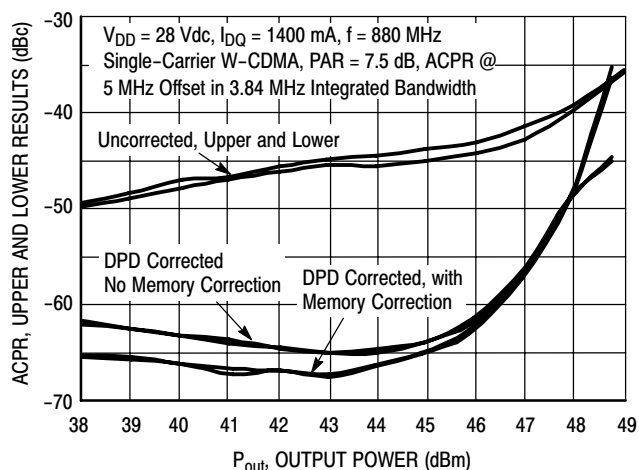


Figure 10. Digital Predistortion Correction versus ACPR and Output Power

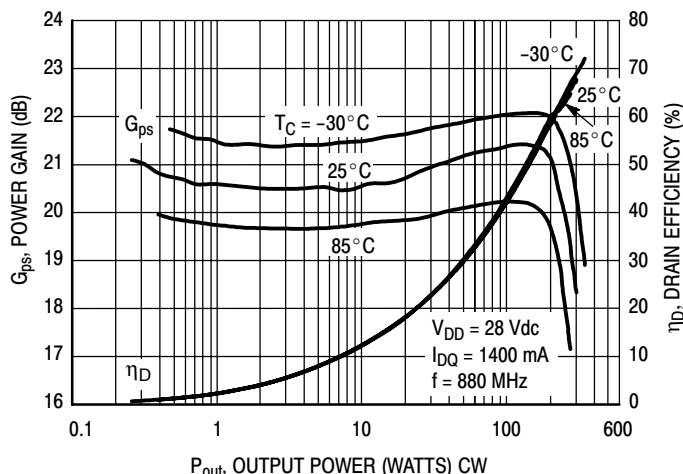


Figure 11. Power Gain and Drain Efficiency versus CW Output Power

TYPICAL CHARACTERISTICS

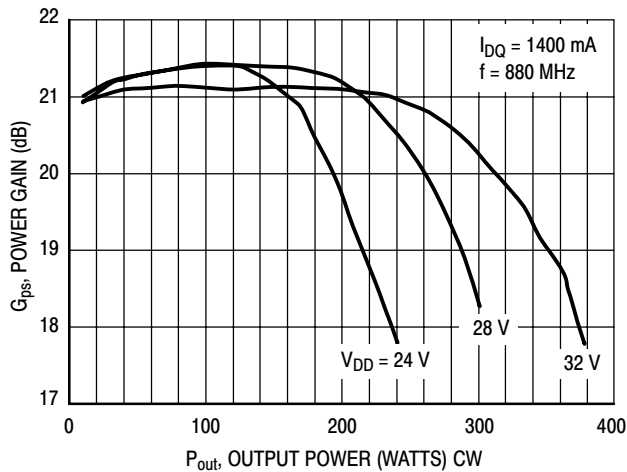
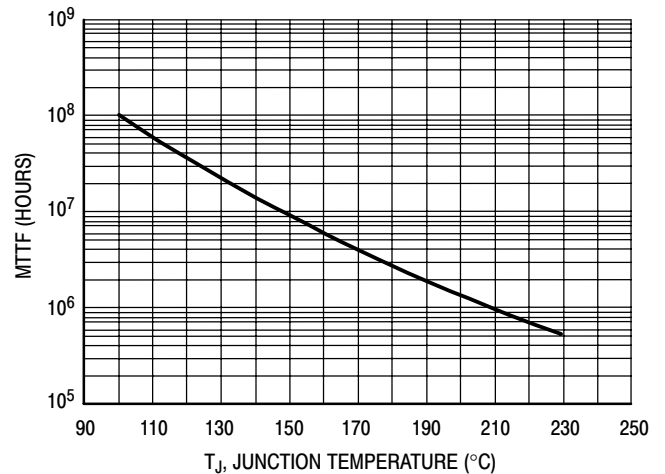


Figure 12. Power Gain versus Output Power



This above graph displays calculated MTTF in hours when the device is operated at $V_{DD} = 28$ Vdc, $P_{out} = 58$ W Avg., and $\eta_D = 35\%$.

MTTF calculator available at <http://www.freescale.com/rf>. Select Software & Tools/Development Tools/Calculators to access MTTF calculators by product.

Figure 13. MTTF versus Junction Temperature

W-CDMA TEST SIGNAL

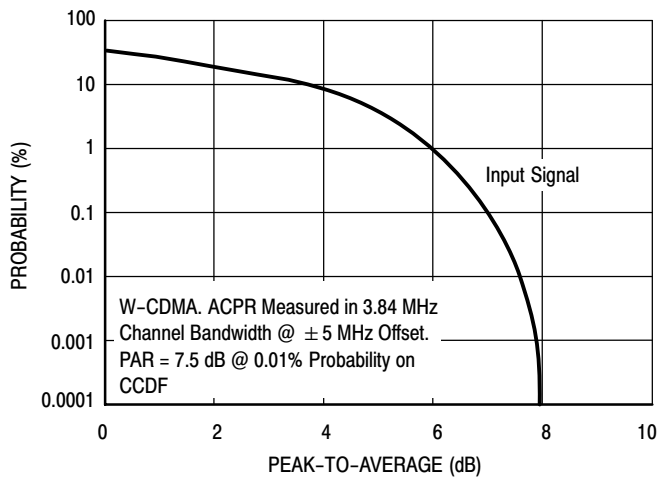


Figure 14. CCDF W-CDMA 3GPP, Test Model 1, 64 DPCH, 50% Clipping, Single-Carrier Test Signal

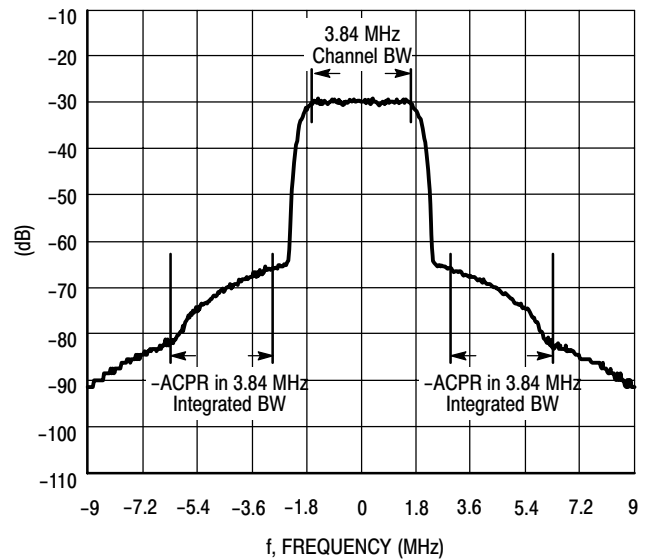
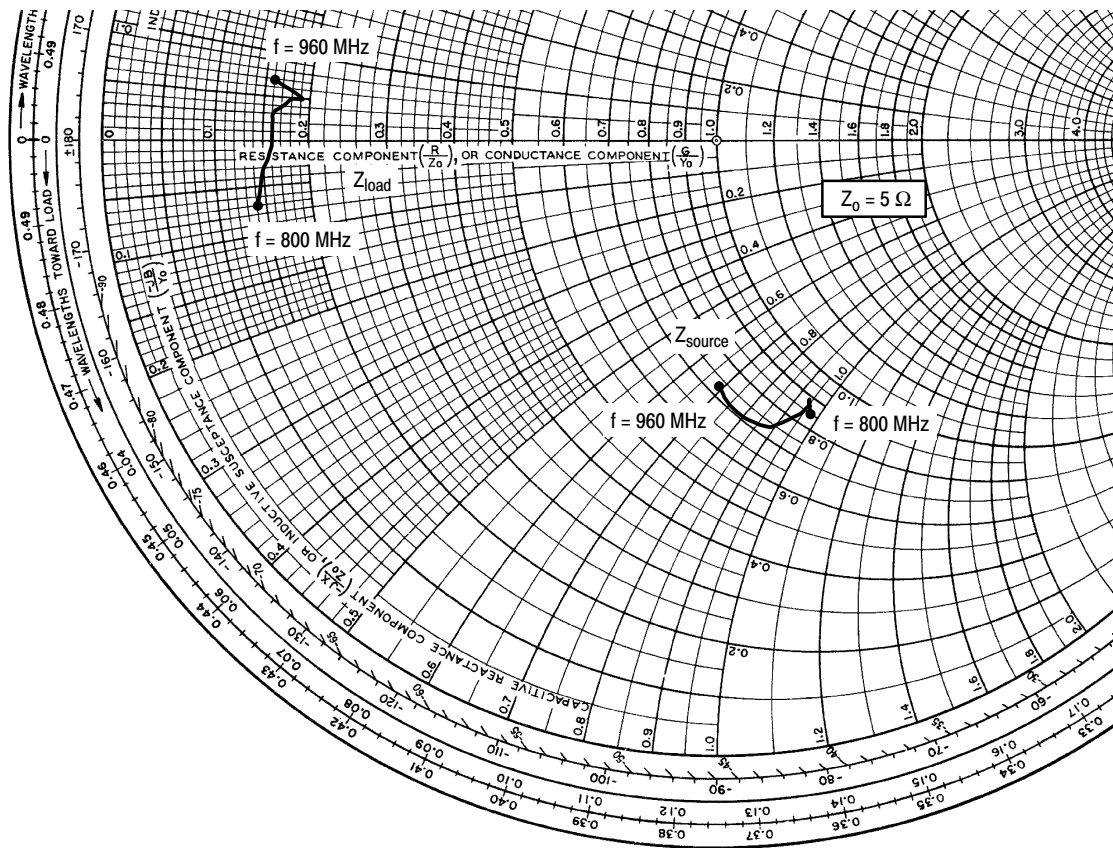


Figure 15. Single-Carrier W-CDMA Spectrum



$V_{DD} = 28 \text{ Vdc}$, $I_{DQ} = 1400 \text{ mA}$, $P_{out} = 58 \text{ W Avg.}$

f MHz	Z_{source} Ω	Z_{load} Ω
800	4.23 - j4.85	0.70 - j0.33
820	4.46 - j4.69	0.76 - j0.13
840	4.39 - j4.75	0.78 - j0.02
860	4.06 - j4.68	0.79 + j0.09
880	3.70 - j4.45	0.81 + j0.16
900	3.55 - j4.04	0.86 + j0.21
920	3.57 - j3.71	0.89 + j0.27
940	3.67 - j3.47	0.89 + j0.31
960	3.67 - j3.45	0.82 + j0.33

Z_{source} = Test circuit impedance as measured from gate to ground.

Z_{load} = Test circuit impedance as measured from drain to ground.

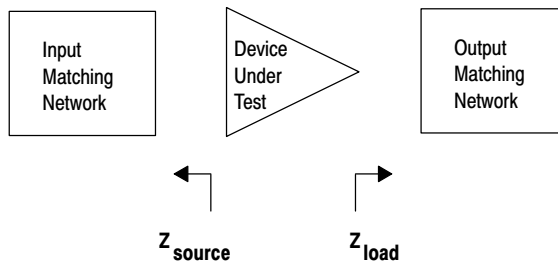
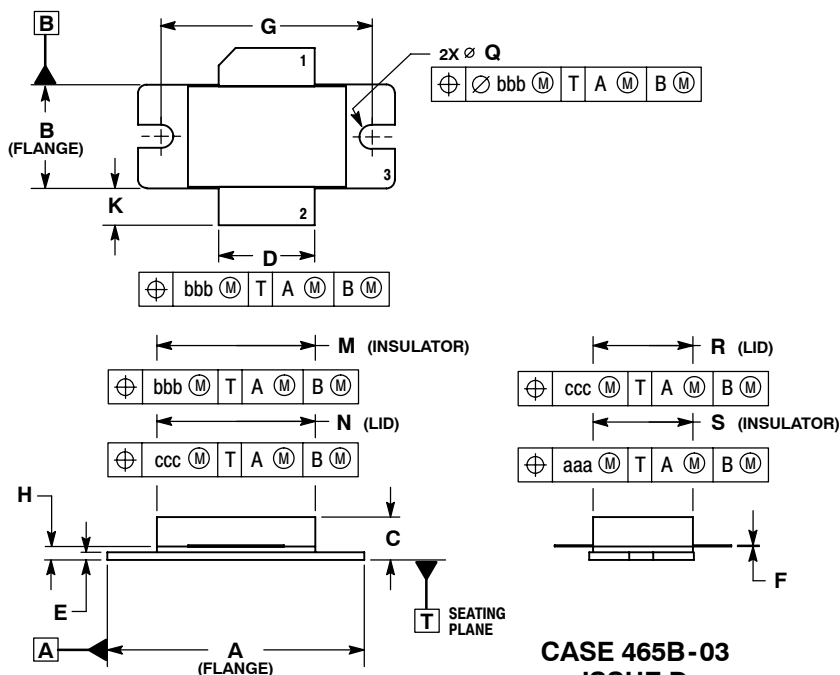


Figure 16. Series Equivalent Source and Load Impedance

PACKAGE DIMENSIONS

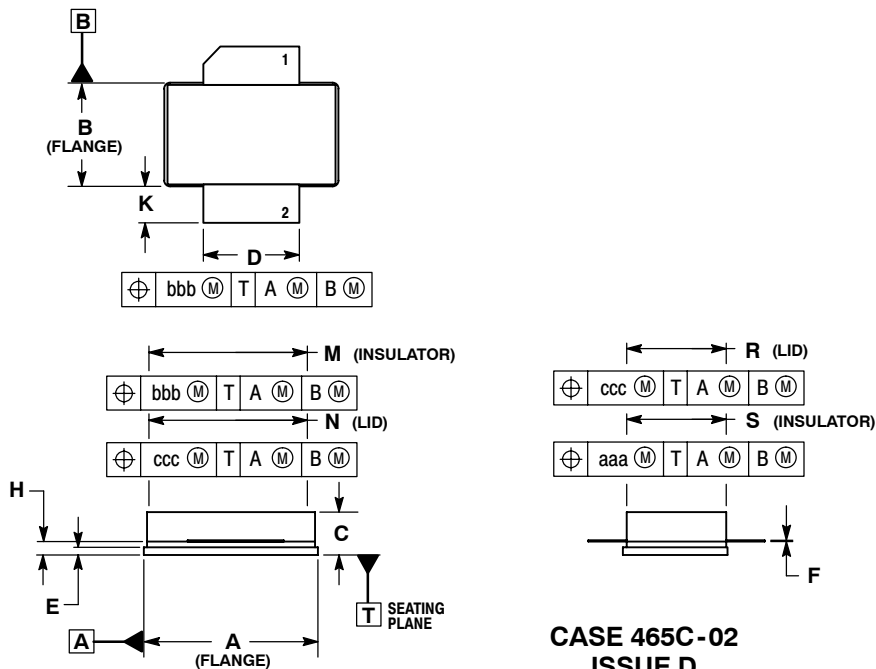


**CASE 465B-03
 ISSUE D
 NI-880
 MRFE6S9200HR3**

- NOTES:
 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M-1994.
 2. CONTROLLING DIMENSION: INCH.
 3. DIMENSION H IS MEASURED 0.030 (0.762) AWAY FROM PACKAGE BODY.
 4. DELETED

DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	1.335	1.345	33.91	34.16
B	0.535	0.545	13.6	13.8
C	0.147	0.200	3.73	5.08
D	0.495	0.505	12.57	12.83
E	0.035	0.045	0.89	1.14
F	0.003	0.006	0.08	0.15
G	1.100 BSC		27.94 BSC	
H	0.057	0.067	1.45	1.70
K	0.170	0.210	4.32	5.33
M	0.872	0.888	22.15	22.55
N	0.871	0.889	19.30	22.60
Q	\varnothing .118	\varnothing .138	\varnothing 3.00	\varnothing 3.51
R	0.515	0.525	13.10	13.30
S	0.515	0.525	13.10	13.30
aaa	0.007 REF		0.178 REF	
bbb	0.010 REF		0.254 REF	
ccc	0.015 REF		0.381 REF	

- STYLE 1:
 PIN 1. DRAIN
 2. GATE
 3. SOURCE



**CASE 465C-02
 ISSUE D
 NI-880S
 MRFE6S9200HSR3**

- NOTES:
 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M-1994.
 2. CONTROLLING DIMENSION: INCH.
 3. DIMENSION H IS MEASURED 0.030 (0.762) AWAY FROM PACKAGE BODY.

DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	0.905	0.915	22.99	23.24
B	0.535	0.545	13.60	13.80
C	0.147	0.200	3.73	5.08
D	0.495	0.505	12.57	12.83
E	0.035	0.045	0.89	1.14
F	0.003	0.006	0.08	0.15
H	0.057	0.067	1.45	1.70
K	0.170	0.210	4.32	5.33
M	0.872	0.888	22.15	22.55
N	0.871	0.889	19.30	22.60
R	0.515	0.525	13.10	13.30
S	0.515	0.525	13.10	13.30
aaa	0.007 REF		0.178 REF	
bbb	0.010 REF		0.254 REF	
ccc	0.015 REF		0.381 REF	

- STYLE 1:
 PIN 1. DRAIN
 2. GATE
 3. SOURCE

PRODUCT DOCUMENTATION

Refer to the following documents to aid your design process.

Application Notes

- AN1955: Thermal Measurement Methodology of RF Power Amplifiers

Engineering Bulletins

- EB212: Using Data Sheet Impedances for RF LDMOS Devices

REVISION HISTORY

The following table summarizes revisions to this document.

Revision	Date	Description
0	Mar. 2007	<ul style="list-style-type: none">• Initial Release of Data Sheet
1	Dec. 2008	<ul style="list-style-type: none">• Updated Full Frequency Band in Typical Performance bullet to $f = 880$ MHz to match actual production test, p. 1• Clarified 3 dB overdrive test condition for HV6E enhanced ruggedness parts, p. 1• Corrected C_{iss} test condition to indicate AC stimulus on the V_{GS} connection versus the V_{DS} connection, Dynamic Characteristics table, p. 2• Changed maximum adjacent channel power ratio specification from -38.5 dBc to -36.5 dBc to match actual production test limits, p. 2• Updated PCB information to show more specific material details, Fig. 1, Test Circuit Schematic, p. 3• Updated Part Numbers in Table 5, Component Designations and Values, to latest RoHS compliant part numbers, p. 3• Deleted output signal data from Fig. 14, CCDF W-CDMA 3GPP, Test Model 1, 64 DPCH, 50% Clipping, Single-Carrier Test Signal, p. 7

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